

*P-Channel Enhancement Mode MOSFET with Schottky Diode*
**DESCRIPTION**

The STC5853 is the P-Channel logic enhancement mode power field effect transistor is produced using high cell density, advanced trench technology to provide excellent  $R_{DS(ON)}$ . This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application, and low in-line power loss are needed in a very small outline surface mount package.

**FEATURE**
**MOSFET**

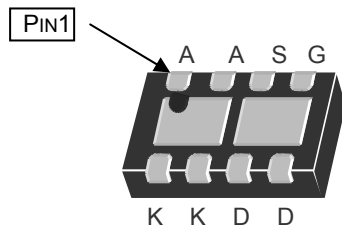
- ◆  $-20V/-3.5A, R_{DS(ON)} = 70m\Omega @ V_{GS} = -4.5V$
- ◆  $-20V/-2.4A, R_{DS(ON)} = 95m\Omega @ V_{GS} = -2.5V$
- ◆  $-20V/-1.8A, R_{DS(ON)} = 125m\Omega @ V_{GS} = -1.8V$

**SCHOTTKY**

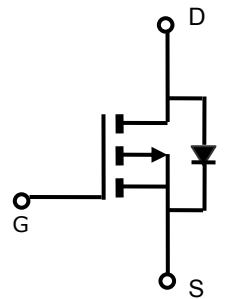
- ◆  $V_{KA} = 20V, V_F = 0.43V(Typ.) @ I_F = 1A$
- ◆ Full RoHS compliance
- ◆ DFN3X2-8L package design

**APPLICATIONS**

- ◆ Battery Powered System
- ◆ Notebook Power Management
- ◆ Cell Phone

**PIN CONFIGURATION**


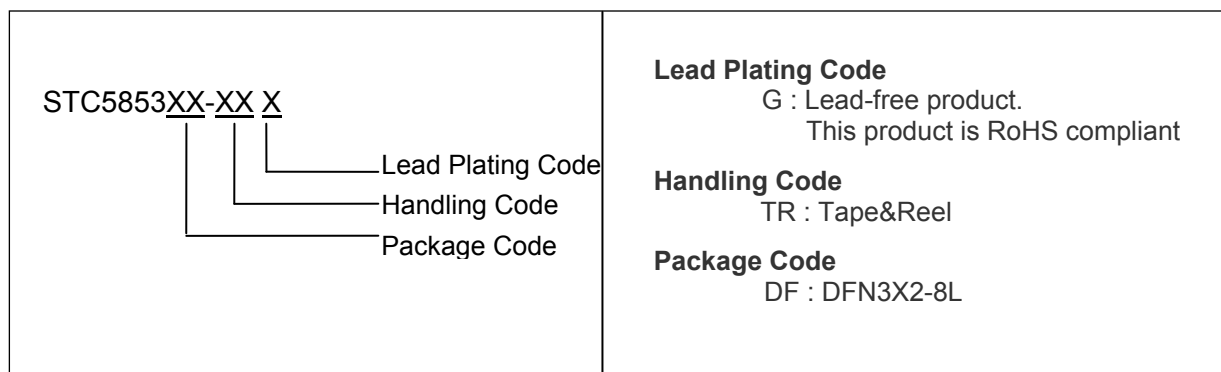
TOP VIEW  
DFN3X2-8L



P-Channel Mosfet



Schottky Diode

**PART NUMBER INFORMATION**


**ORDERING INFORMATION**

Part Number	Package Code	Package	Shipping
STC5853DF-TRG	DF	DFN3X2-8L	3000 /Tape&Reel

※ Year Code : 0 ~ 9

※ Week Code : A ~ Z(1~26) ; a ~ z(27~52)

※ DFN3X2-8L : Only available in tape and reel packaging. (A reel contains 3000 devices)

※ G : Lead-free product. This product is RoHS compliant

**ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25°C Unless otherwise noted )**

Symbol	Parameter	Typical	Unit
<b>P-Channel MOSFET</b>			
V <sub>DSS</sub>	Drain-Source Voltage	-20	V
V <sub>GSS</sub>	Gate-Source Voltage	±12	V
I <sub>D</sub>	Continuous Drain Current (T <sub>J</sub> =150°C)	T <sub>A</sub> =25°C -3.5 T <sub>A</sub> =70°C -2.8	A
I <sub>DM</sub>	Pulsed Drain Current	-15	A
I <sub>S</sub>	Continuous Source Current (Diode Conduction)	-1.4	A
T <sub>J</sub>	Operation Junction Temperature	-55~150	°C
T <sub>STG</sub>	Storage Temperature Range	-55~150	W
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> =25°C 1.25 T <sub>A</sub> =70°C 0.8	W
R <sub>θJA</sub>	Thermal Resistance-Junction to Ambient	T ≤ 10sec 65 Steady State 95	°C/W
<b>Schottky</b>			
V <sub>KA</sub>	Reverse Voltage	20	V
I <sub>F</sub>	Continuous Drain Current	T <sub>A</sub> =25°C 1 T <sub>A</sub> =70°C 0.7	A
I <sub>FM</sub>	Pulsed Drain Current	10	A
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> =25°C 0.9 T <sub>A</sub> =70°C 0.6	W

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

**ELECTRICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  Unless otherwise noted )

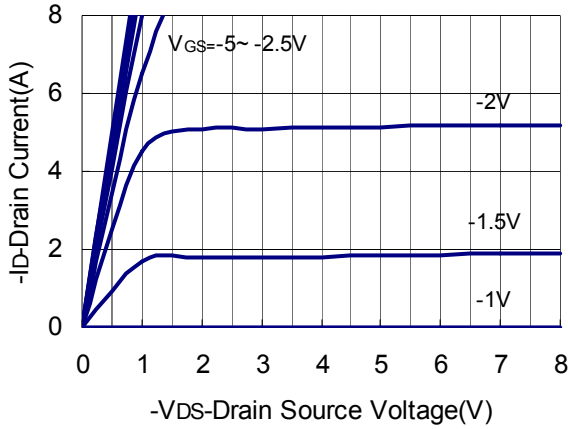
Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>MOSFET Dynamic Parameters</b>						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	-20			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.4		-0.9	V
$I_{GSS}$	Gate Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 12V$			$\pm 100$	nA
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -20V, V_{GS} = 0V$			-1	$\mu A$
		$V_{DS} = -20V, V_{GS} = 0V$ $T_J = 55^\circ\text{C}$			-5	
$R_{DS(ON)}$	Drain-source On-Resistance	$V_{GS} = -4.5V, I_D = -3.5A$ $V_{GS} = -2.5V, I_D = -2.4A$ $V_{GS} = -1.8V, I_D = -1.8A$		70 95 125	80 110 140	m $\Omega$
$G_{fs}$	Forward Transconductance	$V_{DS} = -5V, I_D = -2.8A$		6		S
<b>MOSFET Dynamic Parameters</b>						
$Q_g$	Total Gate Charge	$V_{DS} = -6V, V_{GS} = -4.5V$ $I_D = -2.8A$		4.8	8	nC
$Q_{gs}$	Gate-Source Charge			1.0		
$Q_{gd}$	Gate-Drain Charge			1.0		
$C_{iss}$	Input Capacitance	$V_{DS} = -6V, V_{GS} = 0V$ $f = 1\text{MHz}$		485		pF
$C_{oss}$	Output Capacitance			85		
$C_{riss}$	Reverse Transfer Capacitance			40		
$t_{d(on)}$	Turn-On Time	$V_{DD} = -6V, R_L = 6\Omega$ $I_D = -1.0A, V_{GEN} = -4.5V$ $R_G = 6\Omega$		10	16	nS
$t_r$				13	23	
$t_{d(off)}$	Turn-Off Time			18	25	
$t_f$				15	20	

**ELECTRICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  Unless otherwise noted )

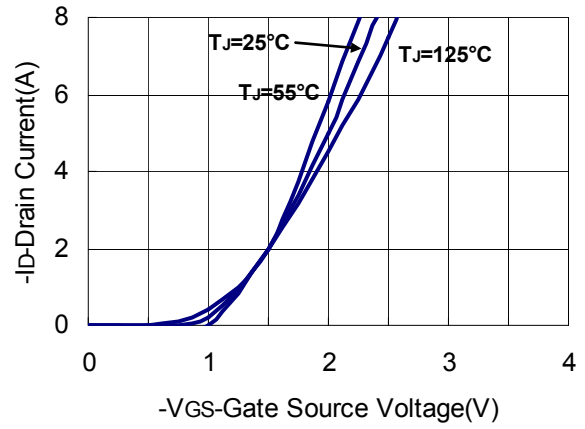
Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Schottky Parameters</b>						
$V_F$	Forward Voltage Drop	$I_F = 1A$		0.43	0.47	V
$V_{BR}$	Reverse Breakdown Voltage	$I_R = 500\mu A$	20			V
$I_{rm}$	Maximum reverse leakage current	$V_R = 23V$ $V_R = 23V, T_J = 70^\circ\text{C}$			0.1 1	mA
$C_T$	Junction Capacitance	$V_R = 10V$ $V_R = 0V, f = 1\text{MHz}$		31 120		pF
$T_{rr}$	Schottky Reverse Recovery Time	$I_F = 1A, di/dt = 100A/\mu s$		5.4	10	nS
$Q_{rr}$	Schottky Reverse Recovery Charge	$I_F = 1A, di/dt = 100A/\mu s$		0.8		nC

## TYPICAL CHARACTERISTICS (MOSFET)

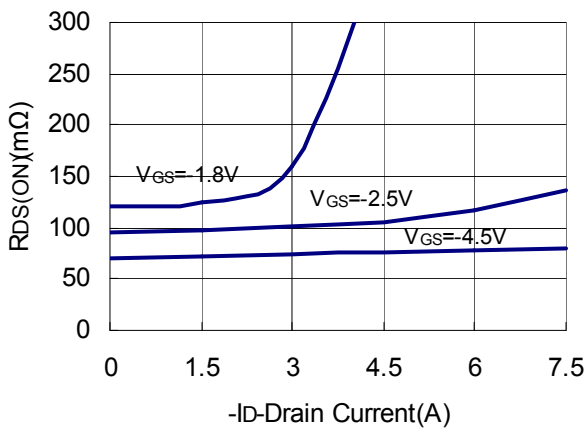
**Output Characteristics**



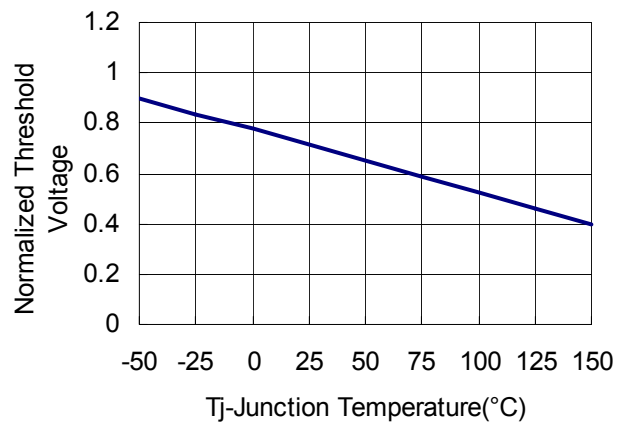
**Transfer Characteristics**



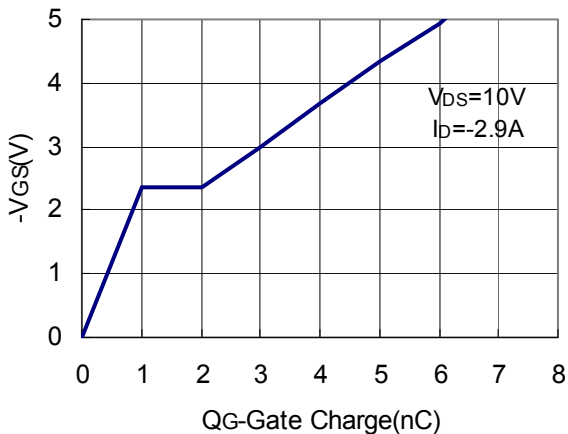
**Drain Source On Resistance**



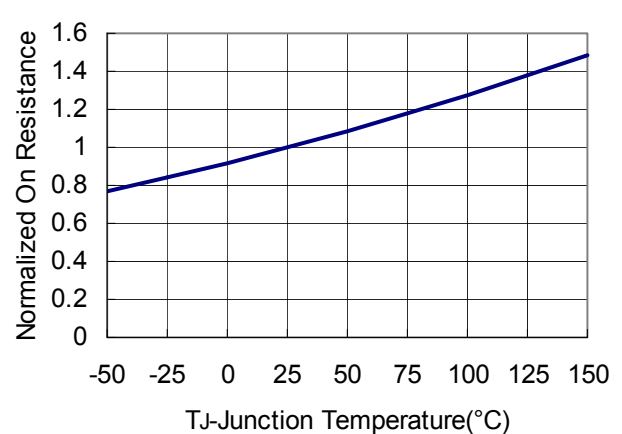
**Gate Threshold Voltage**



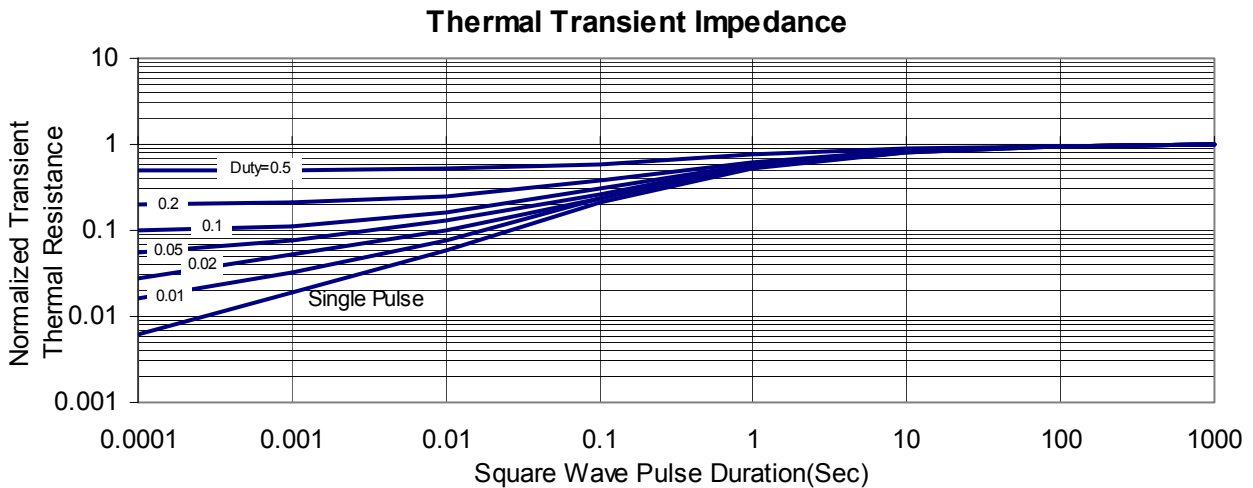
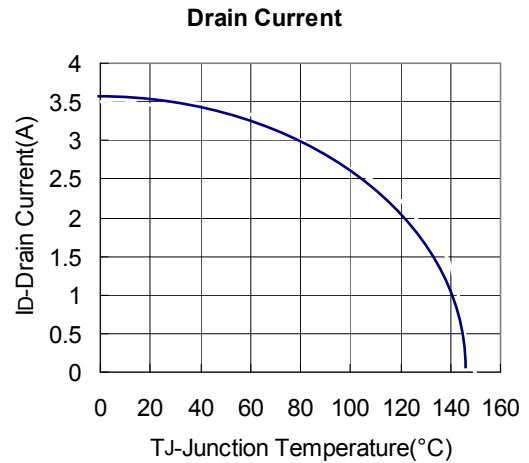
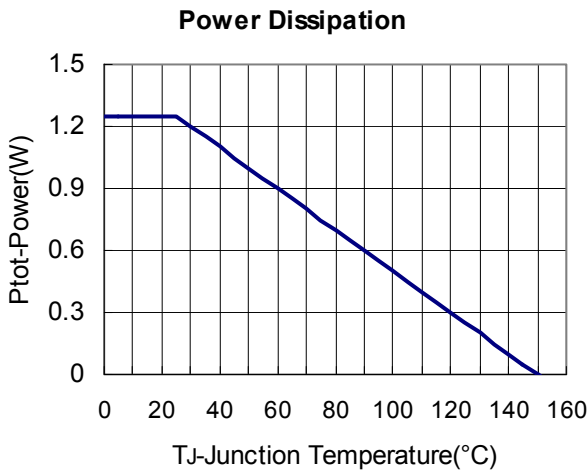
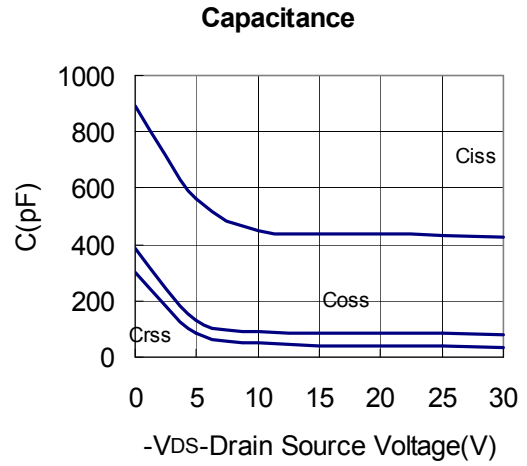
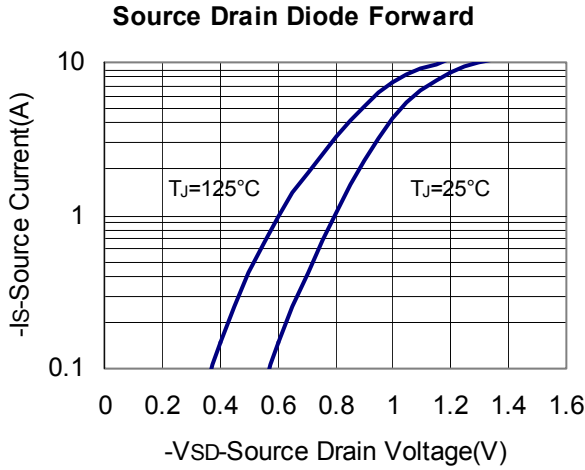
**Gate Charge**



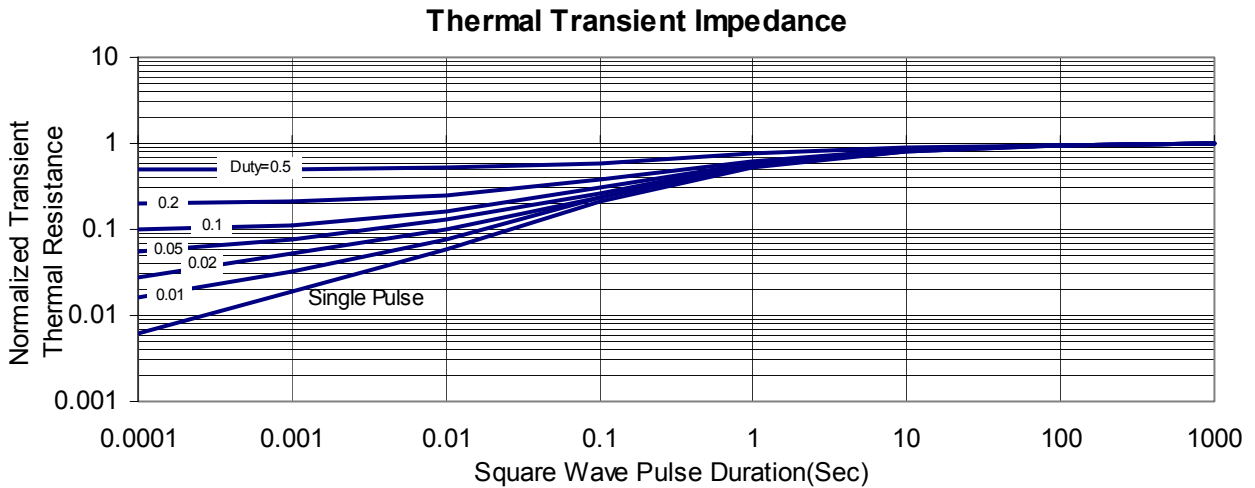
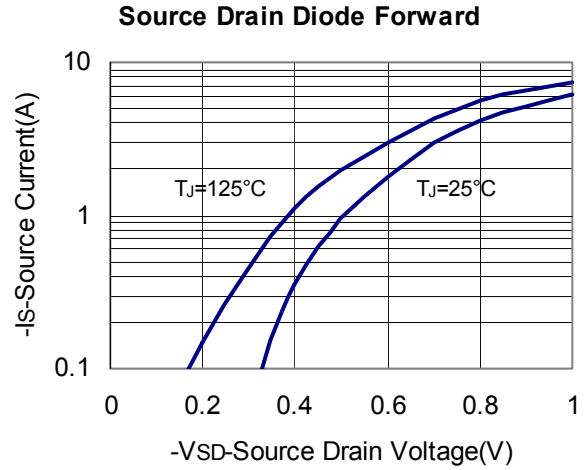
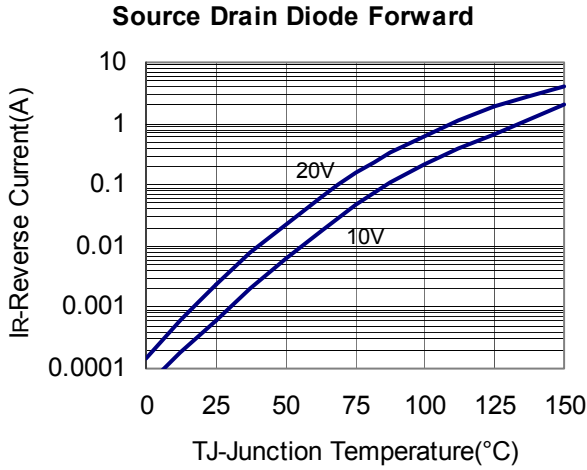
**Drain Source On Resistance**

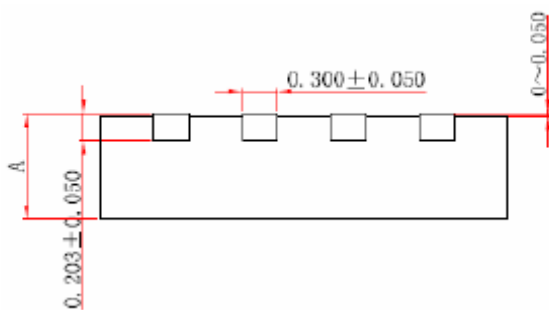
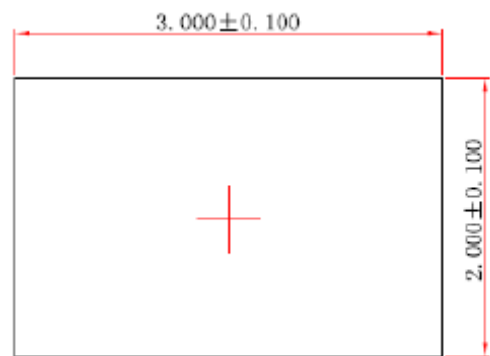
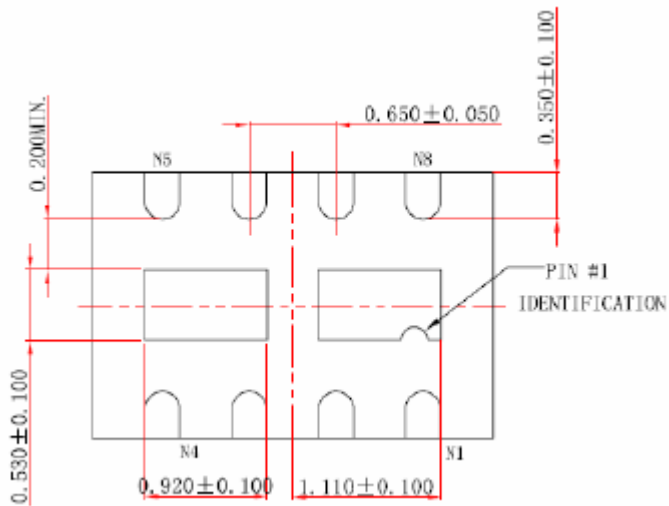


**TYPICAL CHARACTERISTICS (MOSFET)**



**TYPICAL CHARACTERISTICS (Schottky)**



**DFN3x2-8L PACKAGE DIMENSIONS**


	MIN.	MORM.	MAX.
A	0.700	0.750	0.800
	0.800	0.850	0.900